


<b>Search Notes</b> 	<b>Application/Control No.</b> 10535571	<b>Applicant(s)/Patent Under Reexamination</b> KADYK ET AL.
	<b>Examiner</b> JACOB CHEU	<b>Art Unit</b> 1641

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES			
Search Notes		Date	Examiner
Inventor Search (ODP)		11/19/2010	JC
EAST		11/20/2010	JC
STN		11/20/2010	JC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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